積層パワーチョークコイル MULTILAYER CHIP INDUCTORS (FOR POWER SUPPLY LINES) CK SERIES P TYPE

OPERATING TEMP. −40~85°C



特長 FEATURES

- ・3.2×1.6mm、高さ1mm未満のコンパクトサイズ。
- ・内部電極の印刷技術及びセラミックスグリーンシート技術の向上により、 従来の内部電極よりも高アスペクト比のAg厚膜を形成し、大幅な低Rdc化 を実現。
- · Low profile below 1mm on 1206 case size.
- Low DC power dissipation due to Low Rdc with High Aspect Ratio internal conductor that stands on the Green Sheet and Printing technologies.

用途 APPLICATIONS

- ・携帯電話、DSC、DVC等の携帯小型電子機器のDC-DCコンバータ
- DC/DC converter for the Mobile equipments; Cellular Phones, DSC, DVC.

形名表記法 ORDERING CODE



2 形状寸法(L×W)(mm) 3216(1206) 3.2×1.6







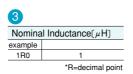


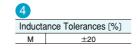




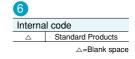
External Dimensions (LXW)(mm)

3216(1206) 3.2×1.6

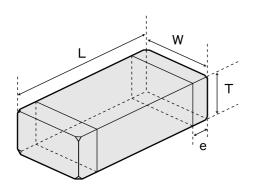








外形寸法 EXTERNAL DIMENSIONS



Туре	L	W	Т	е
CKP3216	3.2±0.2	1.6±0.2	$0.8 ^{+0.10}_{-0.15} $ $(0.031 ^{+0.004}_{-0.006})$	0.5±0.3
(1206)	(0.126±0.008)	(0.063±0.008)		(0.02±0.012)

Unit: mm(inch)

概略バリエーション AVAILABLE INDUCTANCE RANGE

	Туре	CKP3216	Imax
Range			[A]
	1.0	1R0M	1.1
	1.5	1R5M	1.0
inductance $[\mu H]$	2.2	2R2M	0.9
[μH]	3.3	3R3M	0.8
	4.7	4R7M	0.7











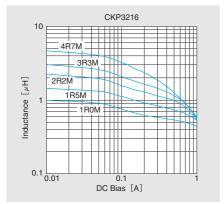


アイテム一覧 PART NUMBERS

CKP3216 ----

0111 02 10								
形 名 Ordering code	EHS (Environmental Hazardous Substances)	公称 インダクタンス Inductance 〔µH〕	インダクタンス 許容差 Inductance tolerance	インダクタンス at 200mA inductance [µH](min.)	直流抵抗 DC resistance [Ω](max.)	定格電流 Rated current (A) (max.)	測定周波数 Measuring frequency [MHz]	厚さ Thickness (mm) (inch)
CKP 3216 1R0M	RoHS	1.0		0.4	0.11	1.1		
CKP 3216 1R5M	RoHS	1.5		0.7	0.13	1.0		0.80 ^{+0.10} -0.15
CKP 3216 2R2M	RoHS	2.2	±20%	1.0	0.14	0.9	1	
CKP 3216 3R3M	RoHS	3.3		1.3	0.16	0.8		(0.031 ^{+0.004} _{-0.006})
CKP 3216 4R7M	RoHS	4.7		1.8	0.20	0.7		

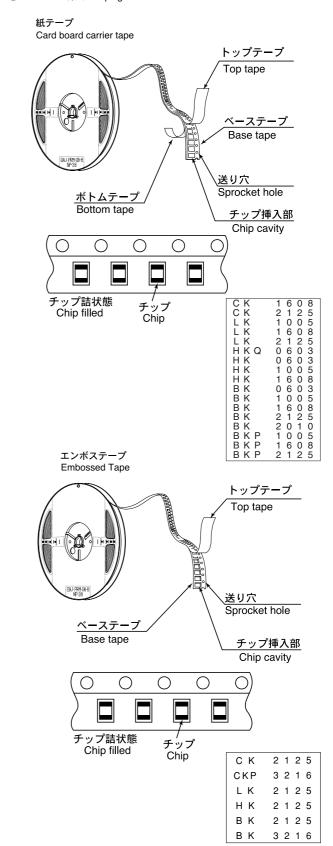
直流重畳特性例 DC Bias characteristics -



①最小受注単位数 Minimum Quantity ■テーピング梱包 Tape & Reel Packaging

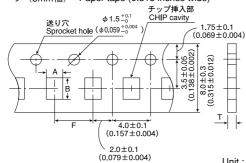
	製品厚み	標準数量	[pcs]
形式	Thickness	Standard	d Quantity
Type	[mm]	紙テープ	エンボステープ
	(inch)	Paper Tape	Embossed Tape
01/4000/0000	0.8	4000	
CK1608(0603)	(0.031)	4000	_
	0.85	4000	_
01/0405/0005)	(0.033)	4000	_
CK2125(0805)	1.25	_	2000
	(0.049)		2000
CKP3216(1206)	0.8	_	4000
CKF 32 TO(1200)	(0.031)		4000
LK1005(0402)	0.5	10000	_
	(0.020)	10000	
LK1608(0603)	0.8	4000	_
	(0.031)	1000	
	0.85	4000	_
LK2125(0805)	(0.033)	4000	
ERE 120(0000)	1.25	_	2000
	(0.049)		
HKQ0603(0201)	0.3	15000	_
	(0.012)		
HK0603(0201)	0.3	15000	_
	(0.012)		
HK1005(0402)	0.5	10000	_
	(0.020)		
HK1608(0603)	0.8	4000	_
	(0.031)		
	0.85	_	4000
HK2125(0805)	(0.033)		
, ,	1.0	_	3000
	(0.039)		
BK0603(0201)	0.3	15000	_
	(0.012)		
BK1005(0402)	0.5	10000	_
	(0.020)		
BK1608(0603)	0.8	4000	_
	(0.031)		
	0.85	4000	_
BK2125(0805)	(0.033)		
	1.25	_	2000
	(0.049)		
BK2010(0804)	0.45	4000	_
	(0.018)		
BK3216(1206)	0.8	_	4000
	(0.031)		
BKP1005(0402)	0.5	10000	_
	(0.020)		
BKP1608(0603)	0.8	4000	-
	(0.031) 0.85		
BKP2125(0805)		4000	-
	(0.033)	1	

②テーピング材質 Taping material



③テーピング寸法 Taping Dimensions

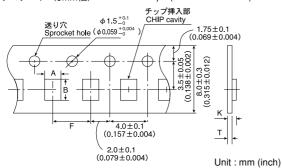
・紙テープ(8mm幅) Paper tape (0.315 inches wide)



Unit	:	mm	(inch)
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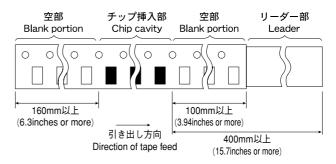
T/ D	製品厚み	チップ	挿入部	挿入ピッチ	テープ厚み
形式	Thickness	Chip	cavity	Insertion Pitch	Tape Thickness
Type	(mm)	A	В	F	Т
01(1,000,0000)	0.8	1.0±0.2	1.8±0.2	4.0±0.1	1.1max
CK1608(0603)	(0.031)	(0.039±0.008)	(0.071±0.008)	(0.157±0.004)	(0.043max)
01/0405/0005)	0.85	1.5±0.2	2.3±0.2	4.0±0.1	1.1max
CK2125(0805)	(0.033)	(0.059±0.008)	(0.091±0.008)	(0.157±0.004)	(0.043max)
L K100E(0400)	0.5	0.65±0.1	1.15±0.1	2.0±0.05	0.8max
LK1005(0402)	(0.020)	(0.026±0.004)	(0.045±0.004)	(0.079±0.002)	(0.031max)
L IZ1000/0000)	0.8	1.0±0.2	1.8±0.2	4.0±0.1	1.1max
LK1608(0603)	(0.031)	(0.039±0.008)	(0.071±0.008)	(0.157±0.004)	(0.043max)
L K010E(000E)	0.85	1.5±0.2	2.3±0.2	4.0±0.1	1.1max
LK2125(0805)	(0.033)	(0.059±0.008)	(0.091±0.008)	(0.157±0.004)	(0.043max)
LIKO0603(0004)	0.3	0.40±0.06	0.70±0.06	2.0±0.05	0.45max
HKQ0603(0201)	(0.012)	(0.016±0.002)	(0.028±0.002)	(0.079±0.002)	(0.018max)
LIK0603/0304)	0.3	0.40±0.06	0.70±0.06	2.0±0.05	0.45max
HK0603(0201)	(0.012)	(0.016±0.002)	(0.028±0.002)	(0.079±0.002)	(0.018max)
LIK100E(0400)	0.5	0.65±0.1	1.15±0.1	2.0±0.05	0.8max
HK1005(0402)	(0.020)	(0.026±0.004)	(0.045±0.004)	(0.079±0.002)	(0.031max)
LIK1000(0000)	0.8	1.0±0.2	1.8±0.2	4.0±0.1	1.1max
HK1608(0603)	(0.031)	(0.039±0.008)	(0.071±0.008)	(0.157±0.004)	(0.043max)
DI/0000/0001)	0.3	0.40±0.06	0.70±0.06	2.0±0.05	0.45max
BK0603(0201)	(0.012)	(0.016±0.002)	(0.028±0.002)	(0.079±0.002)	(0.018max)
BK1005(0402)	0.5	0.65±0.1	1.15±0.1	2.0±0.05	0.8max
BK 1003(0402)	(0.020)	(0.026±0.004)	(0.045±0.004)	(0.079±0.002)	(0.031max)
BK1608(0603)	0.8	1.0±0.2	1.8±0.2	4.0±0.1	1.1max
BK1000(0003)	(0.031)	(0.039±0.008)	(0.071±0.008)	(0.157±0.004)	(0.043max)
BK2125(0805)	0.85	1.5±0.2	2.3±0.2	4.0±0.1	1.1max
DN2123(0003)	(0.033)	(0.059±0.008)	(0.091±0.008)	(0.157±0.004)	(0.043max)
BK2010(0804)	0.45	1.2±0.1	2.17±0.1	4.0±0.1	0.80max
BR2010(0004)	(0.018)	(0.047±0.004)	(0.085±0.004)	(0.157±0.004)	(0.031max)
BKP1005(0402)	0.5	0.65±0.1	1.15±0.1	2.0±0.05	0.8max
DIXF 1003(0402)	(0.020)	(0.026±0.004)	(0.045±0.004)	(0.079±0.002)	(0.031max)
BKP1608(0603)	0.8	1.0±0.2	1.8±0.2	4.0±0.1	1.1max
	(0.031)	(0.039±0.008)	(0.071±0.008)	(0.157±0.004)	(0.043max)
BKP2125(0805)	0.85	1.5±0.2	2.3±0.2	4.0±0.1	1.1max
DIVI 2123(0003)	(0.033)	(0.059±0.008)	(0.091±0.008)	(0.157±0.004)	(0.043max)

・エンボステープ(8mm幅) Embossed Tape (0.312 inches wide)

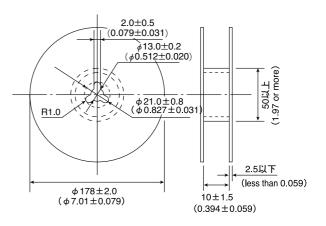


形式	製品厚み	チップ	挿入部	挿入ピッチ	テープ原	₽みmax.
	Thickness	Chip	cavity	Insertion Pitch	Tape Th	nickness
Туре	(mm)	Α	В	F	K	Т
CK2125(0805)	1.25	1.5±0.2	2.3±0.2	4.0±0.1	2.0	0.3
CR2123(0003)	(0.049)	(0.059 ± 0.008)	(0.091±0.008)	(0.157±0.004)	(0.079)	(0.012)
CKP3216(1206)	0.8	1.9±0.1	3.5±0.1	4.0±0.1	1.4	0.3
CKF3210(1200)	(0.031)	(0.075±0.004)	(0.138±0.004)	(0.157±0.004)	(0.055)	(0.012)
LK2125(0805)	1.25	1.5±0.2	2.3±0.2	4.0±0.1	2.0	0.3
LN2123(0603)	(0.049)	(0.059 ± 0.008)	(0.091±0.008)	(0.157±0.004)	(0.079)	(0.012)
	0.85				1.5	
HK2125(0805)	(0.033)	1.5±0.2	2.3±0.2	4.0±0.1	(0.059)	0.3
TIN2123(0003)	1.0	(0.059 ± 0.008)	(0.091±0.008)	(0.157±0.004)	2.0	(0.012)
	(0.039)				(0.079)	
BK2125(0805)	1.25	1.5±0.2	2.3±0.2	4.0±0.1	2.0	0.3
DN2123(0003)	(0.049)	(0.059 ± 0.008)	(0.091±0.008)	(0.157±0.004)	(0.079)	(0.012)
BK2216(1206)	0.8	1.9±0.1	3.5±0.1	4.0±0.1	1.4	0.3
BK3216(1206)	(0.031)	(0.075±0.004)	(0.138±0.004)	(0.157±0.004)	(0.055)	(0.012)

④リーダー部・空部 LEADER AND BLANK PORTION

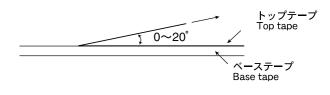


⑤リール寸法 Reel Size



⑥トップテープ強度 Top tape strength

トップテープの剥離力は、下図矢印方向に τ 0.1 \sim 0.7Nとなります。 The top tape requires a peel-off force of 0.1 \sim 0.7N in the direction of the arrow as illustrated below.



										Specifie	ed Value										
Item	BK0603	BK1005	BK1608	BK2125		BK3216		BKP1608	BKP2125	CK1608	CK2125	CKP3216	LK1005	LK1608	LK2125	HKQ0603	HK0603	HK1005	HK1608	HK2125	Test Methods and Remarks
1.Operating Temperature Range			-55~	+125°C	Bricono	DROETO		55~+8	[-40 ~	-+85°C			-	 55~+12	5°C	−40 ~	+85°C	
2.Storage Tem- perature Range			-55~	+125℃			-	55~+8	5℃			-40~	-+85°C			-	55~+12	5°C	-40~	+85℃	
3.Rated Current	100~ 500mA	150~ 1000mA	150~ 1500mA		100mA DC	100~ 200mA	1.0A DC	1.0~ 3.0A	2.0~ 4.0A	40~ 100mA	60~ 500mA	0.7~ 1.1A	10~ 25mA	1~ 50mA	5~ 300mA DC	150~ 400mA	40~ 250mA	110~ 300mA		300mA DC	
4.Impedance	DC 10~ 600Ω ±25%	DC 10~ 1000Ω ±25%	DC 22~ 2500Ω ±25%	DC 15~ 2500Ω ±25%	5~ 600Ω ±25%	DC 68~ 1000Ω ±25%	120Ω ±25%	DC 33~ 390Ω ±25%	DC 33~ 220Ω ±25%	DC	DC	DC	DC	DC	ьс	DC	DC	DC	DC		BK0603 Series: Measuring frequency: 100±1MHz Measuring equipment: HP4291A Measuring jig: 16193A BK1005 Series: BKP1005 Series: Measuring frequency: 100±1MHz Measuring equipment: HP4291A Measuring jig: 16192A, 16193A
														_							BK1608, 2125 Series: BKP1608, 2125 Series: Measuring frequency: 100±1MHz Measuring equipment: HP4291A, HP41 Measuring jig: 16092A or 16192A (HW) BK2010, 3216 Series: Measuring frequency: 100±1MHz
																					Measuring equipment: HP4291A, HP4: Measuring jig: 16192A
5.Inductance					_					2.2~ 10.0#H : ±20%	1	1.0∼ 4.7 µH : ±20% at DC 200mA 0.4∼ 1.8 µH min.	0.12~ 2.2µH : ±10%	0.047~ 33.0 μH : ±20% 0.10~ 12.0 μH : ±10%	0.10∼ 12.0 <i>µ</i> H	1.0~5.6nH :±0.3nH 6.8~10nH :±5%	1.0~6.2nH :±0.3nH 6.8~100nH50 :±5%	: ±0.3nH	1.0~5.6mH :±0.3mH 6.8~470mH :±5%	1.0~56nH :±0.9nH 6.68~470nH :±5%	CK Series: Measuring frequency: 2 to 4MHz (CK160) Measuring frequency: 2 to 25MHz (CK21) Measuring frequency: 11MHz (CKP3216) LK Series: Measuring frequency: 10 to 25MHz (LK16) Measuring frequency: 1 to 50MHz (LK16) Measuring frequency: 0.4 to 50MHz (LK16) Measuring requency: 0.4 to 50MHz (LK2) Measuring equipment, jig: HP4194+16085B+16092A (or its equivale) HP4294+16192A HP4291A+16193A (LK1005) HP4285A+42841A+42842C+ 42851-61100 (CKP3216) Measuring current: 1mA rms (0.047 to 4.7 µH) 0.1mA rms (5.6 to 33 µH) HK Series: Measuring frequency:
																					Measuring frequency: 100MHz (HKQ0603,HK0603, HK1005) Measuring frequency: 50/100MHz (HK1608, HK2125) Measuring equipment, jig: HP4291A+16197A (HKQ0603,HK0603 HP4291A+16193A (HK1005) HP4291A (or its equivalent)+16092A+ in-house made jig (HK1608, 2125)

^{*} Definition of rated current : In the CK and BK Series, the rated current is the value of current at which the temperature of the element is increased within 20°C.

In the BK Series P type and CK Series P type, the rated current is the value of current at which the temperature of the element is increased within 40°C.

In the LK and HK Series, the rated current is either the DC value at which the internal L value is decreased within 5% with the application of DC bias, or the value of current at which the temperature of the element is increased within 20°C.

									Spe	cified	Va	ilue									
Item	BK0603	BK1005	BK1608	BK2125	-	RAY BK3216		BKP1608	BKP2125		CK2125	CKP3216	LK1005	LK1608	LK2125	HKQ0603	HK0603	HK1005	HK1608	HK2125	Test Methods and Remarks
6.Q										20 min.	15~20 min.		10~20 min.	10~35 min.	15~50 min.	4~5 min.	4~5 min.	8min.	8~12 min.	10~18 min.	Measuring frequency: 2 to 4 MHz (CK1608) Measuring frequency: 2 to 25 MHz (CK2125) LK Series: Measuring frequency: 10 to 25 MHz (LK1005) Measuring frequency: 1 to 50 MHz (LK1008) Measuring frequency: 0.4 to 50MHz (LK2125) Measuring equipment, jig: HP4194A + 16085B + 16092A (or its equivalent) HP4195A + 41951 + 16092A (or its equivalent)
												_									HP4294A + 16192A HP4291A + 16193A (LK1005) Measuring current: 1mA rms (0.047 to 4.7μH) 0.1mA rms (5.6 to 33μH) HK Series: Measuring frequency: 100MHz (HKQ0603,HK0603, HK1005) Measuring frequency: 50 / 100MHz (HK1608, 2125) Measuring equipment, jig: HP4291A + 16197A(HKQ0603,HK0603) HP4291A + 16193A(HK1005) HP4195A + 16092A + in-house made jig
7.DC Resistance	0.075~	0.05~	0.05~	0.05~		1		0.025~	1		1	0.11~	0.7~	0.3~	0.20~	0.10~	0.14~	0.08~	0.05~	0.10~	(HK1608, 2125)
8.Self Resonance	1.50Ω max.	0.80Ω max.	1.10Ω max.	0.75Ω max.	0.90Ω max.	0.80Ω max.	max.	0.140Ω max.	0.050Ω max.	(±30%)	max.	0.20Ω max.	1.70Ω max. 40~	2.95Ω max. 9~	1.25Ω max.	0.83Ω max. 4000~	4.0Ω max.	4.8Ω max.	2.6Ω max. 300~	1.5Ω max.	Measuring equipment: VOAC-7412 (made by Iwasaki Tsushinki) VOAC-7512 (made by Iwasaki Tsushinki) LK Series:
Frequency(SRF)										33MHz min.	235MHz min.		180MHz min.	260MHz min.	320MHz min.	min.	nin.	nin.	10000MHz min.	4000MHz min.	Measuring equipment: HP4195A Measuring jig: 41951 + 16092A (or its equivalent) HK Series: Measuring equipment: HP8719C • HP8753D(HK2125)
9.Temperature Characteristic															Inducta Within:	ance cha ±10%	ange:				HK Series: Temperature range: -30 to +85°C Reference temperature: +20°C
10. Resistance to Flexure of Substrate	No me	echanic	eal dama	age.																	Warp: 2mm Testing board: glass epoxy-resin substrate Thickness: 0.8mm Board R-230 Warp Warp Warp Louit mm]

										Specifie	ed Value									
Item	BK0603	BK1005	BK1608	BK2125		RAY BK3216		BKP1608	BKP2125	CK1608	CK2125	CKP3216	LK1005	LK1608	LK2125	HKQ0603	HK0603	HK1005	HK1608 HK2125	Test Methods and Remarks
11.Solderability	At lea	st 75%	of term	ninal ele	ectrode i	is cover	red by i	new sol	der.	At lea	st 75%	of tern	ninal el	ectrode	e is cove	ered by	new so	older.		Solder temperature: 230±5℃ Duration: 4±1 sec.
12.Resistance to Soldering		opearance: No significant abnormality apedance change: Within±30%								No medidamag Remain electro Inducta R10~4 Within: 6R8~1 Within: CKP32 Within:	ning ter de: 70% ance ch 4R7: ±10% 100: ±15%	minal 6 min.	damag Remai	ining te ode: 70 ance ch 4R7: ±10% 330:	rminal % min.	damag Rema electro	ining te ode: 70 ance cl	rminal % min.		Solder temperature: 260±5°C Duration: 10±0.5 sec. Preheating temperature: 150 to 180°C Preheating time: 3 min. Flux: Immersion into methanol solution with colophony for 3 to 5 sec. Recovery: 2 to 3 hrs of recovery under the standard condition after the test. (See Note 1)
13.Thermal Shock			_		t abnorm	ality				No mecha damag Inducta change Within ±20% Qchan Within ±30%	e. ance e:	No mechanical damage. Inductance change: Within ±30%	damag	ance ch ±10% ige:		No me Inducta Qchan	ance ch	nange: \	Within±10%	Conditions for 1 cycle step 1: Minimum operating temperature +0/-3°C 30±3 min. step 2: Room temperature 2 to 3min. step 3: Minimum operating temperature +0/-3°C 30±3 min. step 4: Room temperature 2 to 3min. Number of cycles: 5 Recovery: 2 to 3 hrs of recovery under the standard condition after the test. (See Note 1)

(Note 1) When there are questions concerning mesurement result: measurement shall be made after 48±2 hrs of recovery under the standard condition.

										Spec	cified Value)										
Item						ARRAY				Ė						Т						Test Methods and Remarks
item	BK0603	BK1005	BK1608	BK212		2010 BK3216		BKP1608	BKP2125	CK16	608 CK2125	CKP3216	LK1005	LK1608	LK2125	5 H	HKQ0603	HK0603	HK1005	HK1608	HK2125	
14. Damp Heat	Anne	arance	· No sig	nifican		normality				No		No	No mech	anica	No	+	No me	echanica	damag	e e		BK Series:
(Steady state)										med	hanica	mechanica			mechanic	ca	Induct	tance cha				Temperature: 40±2℃
, ,	Impe	dance o	change:	: Within	n ±30	0%				dam	nage.	damage.		e change:	damage.			n±10%				Humidity: 90 to 95%RH
										Indu	ictance	Inductance change:	Within±1	0%	Inductano change:	ce	Q cha	inge: With	nin±20%	%		Duration: 500 ⁺²⁴ hrs
										With	nin	Within	Q change		Within							Recovery: 2 to 3 hrs of recovery under the
										±20		±30%	Within±3	0%	±10%							standard condition after the removal
										Q cl With ±30					Q change Within ±30%	e:						from test chamber.(See Note1)
																						LK, CK, HK Series:
																						Temperature: 40±2℃ (LK, CK Series)
																						60±2°C (HK Series)
																						Humidity: 90 to 95%RH
																						Duration: 500±12 hours
																						Recovery: 2 to 3 hrs of recovery under the standard condition after the removal
																						from test chamber. (See Note1)
15.Loading under	No me	echanic	cal dam	age In	nduct	ance chang	ne			No		No	No	No	No	+	No me	echanica	daman	e.		BK Series:
Damp Heat			uaili	.agu, 111	.uuuli		- ~			med	hanica	mechanica	mechanica	mechanica	mechanic	ca	Induct	tance cha n±10%				Temperature: 40±2°C (LK Series)
	Within	±30%								dam	nage.	damage.	damage.	damage.	damage.		Within	1±10%				Humidity: 90 to 95%RH
										Indu	ictance	Inductance change:	Inductance change:	Inductance change:	Inductano change:	ce	Q cha	inge: With	nin±20%	%		Duration: 500 ⁺²⁴ hrs
										With	nin	Within	Within	0.047 to	Within							Applied current: Rated current
										±20)%	±30%	±10%	12.0 µH: Within	±10%							Recovery: 2 to 3 hrs of recovery under the
										Q cl With	nange:		Q change: Within	±10% 15.0 to	Q change Within	e:						standard condition after the removal
										±30			±30%	33.0 µH:	±30%							from test chamber. (See Note1)
														Within ±15%								
														Q change:								LK, CK, HK Series:
														Within								Temperature: 40±2°C (LK, CK Series)
														±30%								60±2°C (HK Series) Humidity: 90 to 95%RH
																						Duration: 500±12 hrs
																						Applied current: Rated current
																						Recovery: 2 to 3 hrs of recovery under the
																						standard condition after the removal
																						from test chamber. (See Note1)
16.Loading at	Appe	arance	No sig	nifican	nt abn	ormality				No	honina	No mechanica	No	No mechanica	No mechanic			echanica tance cha		e.		BK Series:
High	Imped	dance o	change:	Within	n ±30	0%					hanica nage.	damage.	damage.	damage.	damage.			1±10%	uige.			Temperature: 125±3℃
Temperature										Indu	ıctance	Inductance	Inductance	Inductance	Inductano	ce	Q cha	ınge: With	nin±20%	%		Applied current: Rated current
										cha With		change: Within	change: Within	change: 0.047 to	change: Within							Duration: 500 ⁺²⁴ ₋₀ hrs Recovery: 2 to 3 hrs of recovery under the
										±20		±30%	±10%	12.0 µH:	±10%							standard condition after the removal
										Q cl	nange:		Q change:	Within ±10%	Q change	e:						from test chamber. (See Note1)
										With ±30	nin -		Within ±30%	15.0 to	Within ±30%							,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,
														±15%								LK, CK, HK Series, BK Series P type:
														Q change:								Temperature: 85±2°C (LK, CK Series)
														Within ±30%								: 85±3°C (BK Series P type)
																						: 85±2°C (HK 1608, 2125)
																						: 85±2°C (HK 1005 operating
																						temperature range -55 to +85°C)
																						: 125±2°C (HKQ 0603,HK 0603, HK1005)
																						operating temperature range
																						-55 to +125℃)
																						Applied current: Rated current
																						Duration: 500±12 hrs Recovery: 2 to 3 hrs of recovery under the
																						standard condition after the removal
																						from test chamber. (See Note1)
										1		1			1							ironi tost orianibei. (See Note1)

Note on standard condition: "standard condition" referred to herein is defined as follows:

5 to $35^\circ\!\!\!\!\mathrm{C}$ of temperature, 45 to 85% relative humidity, and 86 to 106kPa of air pressure.

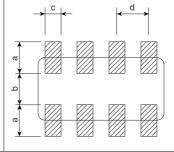
When there are questions concerning measurement results:

In order to provide correlation data, the test shall be conducted under condition of 20±2°C of temperature, 60 to 70% relative humidity, and 86 to 106kPa of air pressure. Unless otherwise specified, all the tests are conducted under the "standard condition."

(Note 1)

measurement shall be made after 48 ± 2 hrs of recovery under the standard condition.

	Precautions			Technical co	nsiderations		
Circuit Design	 ◆ Verification of operating environment, electrical rating and performance 1. A malfunction in medical equipment, spacecraft, nuclear reactors, etc. may cause serious harm to human life or have severe social ramifications. As such, any inductors to be used in such equipment may require higher safety and/or reliability considerations and should be clearly differentiated from components used in general purpose applications. ◆ Operating Current (Verification of Rated current) 1. The operating current for inductors must always be lower than their rated values. 2. Do not apply current in excess of the rated value because the inductance may be reduced due to the magnetic saturation effect. 						
. PCB Design	◆Pattern configurations (Design of Land-patterns) 1. When inductors are mounted on a PCB, the amount of solder used (size of fillet) can directly affect inductor performance. Therefore, the following items must be carefully considered in the design of solder land patterns: (1) The amount of solder applied can affect the ability of chips to withstand mechanical stresses which may lead to breaking or cracking. Therefore, when designing	patterns the com also sho	to prevent exc ponent end te own.		mounts (larger fi amples of impro	illets which exte oper pattern de	end above esigns are atterns for
	land-patterns it is necessary to consider the appropriate size and configuration of the solder pads which in turn determines the amount of solder necessary to form the fillets. (2) When more than one part is jointly soldered onto the same land or pad, the pad must be designed so that each component's soldering point is separated by solder-resist.	Recomme Type Solution Recomme Type A B C		2125 2.0 1.25 1.0~1.4 0.8~1.5 0.9~1.2	e-soldering (ui 3216 3.2 1.6 1.8~2.5 0.8~1.7 1.2~1.6	it: mm)	
	ate size and configuration of the solder pads which in turn determines the amount of solder necessary to form the fillets. (2) When more than one part is jointly soldered onto the same land or pad, the pad must be designed so that each component's soldering point is separated by sol-	Type Signature M A B C	1608 1.6 0.8 0.8~1.0 0.5~0.8 0.6~0.8	2125 2.0 1.25 1.0~1.4 0.8~1.5 0.9~1.2 ensions for refle	3216 3.2 1.6 1.8~2.5 0.8~1.7 1.2~1.6 w-soldering (u	ınit: mm)	2016
	ate size and configuration of the solder pads which in turn determines the amount of solder necessary to form the fillets. (2) When more than one part is jointly soldered onto the same land or pad, the pad must be designed so that each component's soldering point is separated by sol-	Type Column Colu	1608 1.6 0.8 0.8~1.0 0.5~0.8 0.6~0.8	2125 2.0 1.25 1.0~1.4 0.8~1.5 0.9~1.2 ensions for reflo	3216 3.2 1.6 1.8~2.5 0.8~1.7 1.2~1.6 ow-soldering (u	init: mm) 2125	3216
	ate size and configuration of the solder pads which in turn determines the amount of solder necessary to form the fillets. (2) When more than one part is jointly soldered onto the same land or pad, the pad must be designed so that each component's soldering point is separated by sol-	Type Size W A B C Recomme Type Size L W A B C	1608 1.6 0.8 0.8~1.0 0.5~0.8 0.6~0.8 nded land dim- 0603 0.6	2125 2.0 1.25 1.0~1.4 0.8~1.5 0.9~1.2 ensions for reflocations for r	3216 3.2 1.6 1.8~2.5 0.8~1.7 1.2~1.6 ow-soldering (u 1608 1.6	unit: mm) 2125 2.0	3.2
	ate size and configuration of the solder pads which in turn determines the amount of solder necessary to form the fillets. (2) When more than one part is jointly soldered onto the same land or pad, the pad must be designed so that each component's soldering point is separated by sol-	Type Size W A B C Recomme Type Size W W	1608 1.6 0.8 0.8~1.0 0.5~0.8 0.6~0.8 nded land dimensions 0603 0.6 0.3	2125 2.0 1.25 1.0~1.4 0.8~1.5 0.9~1.2 ensions for reflor 1005 1.0	3216 3.2 1.6 1.8~2.5 0.8~1.7 1.2~1.6 w-soldering (u 1608 1.6 0.8	unit: mm) 2125 2.0 1.25	3.2 1.6
	ate size and configuration of the solder pads which in turn determines the amount of solder necessary to form the fillets. (2) When more than one part is jointly soldered onto the same land or pad, the pad must be designed so that each component's soldering point is separated by sol-	Type Size W A B C Recomme Type Size L W A B C	1608 1.6 0.8 0.8~1.0 0.5~0.8 0.6~0.8 nded land dim- 0603 0.6	2125 2.0 1.25 1.0~1.4 0.8~1.5 0.9~1.2 ensions for reflocations for r	3216 3.2 1.6 1.8~2.5 0.8~1.7 1.2~1.6 ow-soldering (u 1608 1.6	unit: mm) 2125 2.0	3.2



Recommended land dimension for Reflow-soldering (unit: mm)

		3216	2010	
Size	L	3.2	2.0	
že	W	1.6	1.0	
a	ı	0.7~0.9	0.5~0.6	
t)	0.8~1.0	0.5~0.6	
C	;	0.4~0.5	0.2~0.3	
d		0.8	0.5	

Stages	Precautions		Technical consider	rations	
2.PCB Design		(2) Example:	s of good and bad solder app	lication	
			Not recommended	Recommended	
		Mixed mounting of SMD and leaded compo- nents	Lead wire of component.	Solder-resist	
			C o m p o n e n t placement close to the chassis	Chassis — Solder(for grounding)	Solder-resist
		Hand-soldering of leaded com- ponents near mounted compo- nents	Lead wire of component- Soldering iron	Solder-resist-	
		Horizontal com- ponent place- ment		Solder-resist	
	 ◆Pattern configurations (Inductor layout on panelized [breakaway] PC boards) 1. After inductors have been mounted on the boards, chips can be subjected to mechanical stresses in subsequent manufacturing processes (PCB cutting, board inspection, mounting of additional parts, assembly into the chassis, wave soldering the reflow soldered boards etc.) For this reason, planning pattern configurations and the position of SMD inductors should be carefully performed to minimize stress. 	1-1. The following are examples of good and bad inductor layout; SMD inductors should be located to minimize any possible mechanical stresses from board warp or deflection.			
		Item	Not recommended	Recommended	
		tion, mounting of additional parts, assembly into the chassis, wave soldering the reflow soldered boards etc.) For this reason, planning pattern configurations and	Deflection of the board		Position the component at a right angle to the direction of the mechanical stresses that are anticipated.
		1-2. To layout the inductors for the breakaway PC board, it should be not the amount of mechanical stresses given will vary depending on in layout. An example below should be counted for better design.	n will vary depending on inductor		
		Perfora	\ c	D	
		Slit Magnitude of stress A>B = C>D>E			
		cal stress or following me	ing PC boards along their per the inductors can vary accordithods are listed in order from	forations, the amount of mechani- ording to the method used. The n least stressful to most stressful: on. Thus, any ideal SMD inductor	

layout must also consider the PCB splitting procedure.

Stages	Precautions		Technical consider	rations
3.Considerations for automatic placement	◆Adjustment of mounting machine 1. Excessive impact load should not be imposed on the inductors when mounting onto the PC boards. 2. The maintenance and inspection of the mounter should be conducted periodically.	on the inducto be considered (1)The lower limi the PC board (2)The pick-up p (3)To reduce the up nozzle, sup	ors, causing damage. To avoid before lowering the pick-up of the pick-up nozzle should after correcting for deflection ressure should be adjusted by amount of deflection of the boporting pins or back-up pins st	be adjusted to the surface level of
			Improper method	Proper method
		Single-sided mounting	chipping	supporting pins or back-up pins
		Double-sided mounting	chipons or cracking	supporting pins- or back-up pins
		chipping or cr inductors. To a in the stopped	racking of the inductors beca avoid this, the monitoring of the	nt of the nozzle height can cause use of mechanical impact on the e width between the alignment pin nspection and replacement of the
	◆Selection of Adhesives 1. Mounting inductors with adhesives in preliminary assembly, before the soldering stage, may lead to degraded inductor characteristics unless the following factors are appropriately checked; the size of land patterns, type of adhesive, amount applied, hardening temperature and hardening period. Therefore, it is impera-	between the s may result in little or too mu	shrinkage percentage of the a stresses on the inductors and ich adhesive applied to the bo nt, so the following precaution	lation resistance. The difference idhesive and that of the inductors dilead to cracking. Moreover, too pard may adversely affect compons should be noted in the applica-
	tive to consult the manufacturer of the adhesives on proper usage and amounts of adhesive to use.	a. The adhesive mounting & b. The adhesive c. The adhesive d. The adhesive e. The adhesive f. The adhesive g. The adhesive g. The adhesive	esive characteristics should be strong enough to h solder process. should have sufficient strengt should have good coating and should be used during its pre should harden rapidly must not be contaminated. should have excellent insulat should not be toxic and have	d thickness consistency. scribed shelf life. ion characteristics.

Stages	Precaution	Technical considerations		
3.Considerations for automatic placement		When using adhesives to mount inductors on a PCB, inappropriate amounts adhesive on the board may adversely affect component placement. Too li adhesive may cause the inductors to fall off the board during the solder proce. Too much adhesive may cause defective soldering due excessive flow of ad sive on to the land or solder pad.		
		[Recommended conditions]		
		Figure 0805 case sizes as examples		
		a 0.3mm min		
		b 100 ~120 μm		
		c Area with no adhesive		
		Amount of adhesives After inductors are bonded		
1. Since flux may have a significant effect on the performance of inductors, it is necessary to verify the following conditions prior to use; (1) Flux used should be with less than or equal to 0.1 wt% (Chlorine conversion method) of halogenated content. Flux having a strong acidity content should not be applied. (2) When soldering inductors on the board, the amount of flux applied should be controlled at the optimum level. (3) When using water-soluble flux, special care should be taken to properly clean the boards.		1-1. When too much halogenated substance (Chlorine, etc.) content is used to activate the flux, or highly acidic flux is used, an excessive amount of residue after soldering may lead to corrosion of the terminal electrodes or degradation of insulation resistance on the surface of the Inductor. 1-2. Flux is used to increase solderability in flow soldering, but if too much is applied, a large amount of flux gas may be emitted and may detrimentally affect solderability. To minimize the amount of flux applied, it is recommended to use a flux-bubbling system. 1-3. Since the residue of water-soluble flux is easily dissolved by water content in the air, the residue on the surface of Inductor in high humidity conditions may cause a degradation of insulation resistance and therefore affect the reliability of the components. The cleaning methods and the capability of the machines used should also be considered carefully when selecting water-soluble flux.		
	◆Soldering Temperature, time, amount of solder, etc. are specified in accordance with the following recommended conditions.			

Stages	Precautions	Technical considerations
	Precautions And please contact us about peak temperature when you use lead-free paste.	Recommended conditions for soldering [Reflow soldering] Temperature profile Temperature Temperature Temperatu
		components. **Assured to be soldering iron for 1 time. Note: The above profiles are the maximum allowable soldering condition, therefore these profiles are not always recommended. Caution 1. Use a 20W soldering iron with a maximum tip diameter of 1.0 mm. 2. The soldering iron should not directly touch the inductor.
5.Cleaning	◆Cleaning conditions 1. When cleaning the PC board after the Inductors are all mounted, select the appropriate cleaning solution according to the type of flux used and purpose of the cleaning (e.g. to remove soldering flux or other materials from the production process.)	The use of inappropriate solutions can cause foreign substances such as flux residue to adhere to the inductor, resulting in a degradation of the inductor's electrical properties (especially insulation resistance).

Stages	Precautions	Technical considerations
5.Cleaning	Cleaning conditions should be determined after verifying, through a test run, that the cleaning process does not affect the inductor's characteristics.	2. Inappropriate cleaning conditions (insufficient or excessive cleaning) may detrimentally affect the performance of the inductors. (1)Excessive cleaning In the case of ultrasonic cleaning, too much power output can cause excessive vibration of the PC board which may lead to the cracking of the inductor or the soldered portion, or decrease the terminal electrodes' strength. Thus the following conditions should be carefully checked; Ultrasonic output Below 20 w/ℓ Ultrasonic frequency Below 40 kHz Ultrasonic washing period 5 min. or less
6. Post cleaning processes	 ◆Application of resin coatings, moldings, etc. to the PCB and components. 1. With some type of resins a decomposition gas or chemical reaction vapor may remain inside the resin during the hardening period or while left under normal storage conditions resulting in the deterioration of the inductor's performance. 2. When a resin's hardening temperature is higher than the inductor's operating temperature, the stresses generated by the excess heat may lead to inductor damage or destruction. 3. Stress caused by a resin's temperature generated expansion and contraction may damage inductors. The use of such resins, molding materials etc. is not recommended. 	
7. Handling	 ◆Breakaway PC boards (splitting along perforations) 1. When splitting the PC board after mounting inductors and other components, care is required so as not to give any stresses of deflection or twisting to the board. 2. Board separation should not be done manually, but by using the appropriate devices. ◆General handling precautions 1. Always wear static control bands to protect against ESD. 2. Keep the inductors away from all magnets and magnetic objects. 3. Use non-magnetic tweezers when handling inductors. 4. Any devices used with the inductors (soldering irons, measuring instruments) should be properly grounded. 5. Keep bare hands and metal products (i.e., metal desk) away from chip electrodes or conductive areas that lead to chip electrodes. 6. Keep inductors away from items that generate magnetic fields such as speakers or coils. ◆Mechanical considerations 1. Be careful not to subject the inductors to excessive mechanical shocks. (1) If inductors are dropped on the floor or a hard surface they should not be used. (2) When handling the mounted boards, be careful that the mounted components do not come in contact with or bump against other boards or components. 	

Stages	Precautions	Technical considerations
8. Storage conditions	◆Storage 1. To maintain the solderability of terminal electrodes and to keep the packaging material in good condition, care must be taken to control temperature and humidity in the storage area. Humidity should especially be kept as low as possible. Recommended conditions Ambient temperature Below 40 ℃ Humidity Below 70% RH The ambient temperature must be kept below 30 ℃. Even under ideal storage conditions inductor electrode solderability decreases as time passes, so inductors should be used within 6 months from the time of delivery. *The packaging material should be kept where no chlorine or sulfur exists in the air.	If the parts are stocked in a high temperature and humidity environment, problems such as reduced solderability caused by oxidation of terminal electrodes and deterioration of taping/packaging materials may take place. For this reason, components should be used within 6 months from the time of delivery. If exceeding the above period, please check solderability before using the inductors